



TPS22966 5.5-V, 6-A, 16-mΩ On-Resistance Dual-Channel Load Switch

1 Features

- Input Voltage Range: 0.8 V to 5.5 V
- Integrated Dual-Channel Load Switch
- On-Resistance
 - $R_{ON} = 16\text{ m}\Omega$ at $V_{IN} = 5\text{ V}$ ($V_{BIAS} = 5\text{ V}$)
 - $R_{ON} = 16\text{ m}\Omega$ at $V_{IN} = 3.6\text{ V}$ ($V_{BIAS} = 5\text{ V}$)
 - $R_{ON} = 16\text{ m}\Omega$ at $V_{IN} = 1.8\text{ V}$ ($V_{BIAS} = 5\text{ V}$)
- 6-A Maximum Continuous Switch Current per Channel
- Low Quiescent Current
 - 80 μA (Both Channels)
 - 60 μA (Single Channel)
- Low Control Input Threshold Enables Use of 1.2-, 1.8-, 2.5-, and 3.3-V Logic
- Configurable Rise Time
- Quick Output Discharge (QOD) (Optional)
- SON 14-Pin Package With Thermal Pad
- ESD Performance Tested per JESD 22
 - 2-kV HBM and 1-kV CDM

2 Applications

- Ultrabook™
- Notebooks and Netbooks
- Tablet PCs
- Consumer Electronics
- Set-top Boxes and Residential Gateways
- Telecom Systems
- Solid-State Drives (SSD)

3 Description

The TPS22966 is a small, low R_{ON} , dual-channel load switch with controlled turnon. The device contains two N-channel MOSFETs that can operate over an input voltage range of 0.8 V to 5.5 V and can support a maximum continuous current of 6 A per channel. Each switch is independently controlled by an on and off input (ON1 and ON2), which can interface directly with low-voltage control signals. In TPS22966, a 220- Ω on-chip load resistor is added for quick-output discharge when switch is turned off.

The TPS22966 is available in a small, space-saving 2-mm \times 3-mm 14-SON package (DPU) with integrated thermal pad allowing for high power dissipation. The device is characterized for operation over the free-air temperature range of -40°C to $+105^{\circ}\text{C}$.

Device Information⁽¹⁾

| PART NUMBER | PACKAGE | BODY SIZE (NOM) |
|-------------|-----------|--------------------------|
| TPS22966 | WSON (14) | 3.00 mm \times 2.00 mm |

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Application Circuit

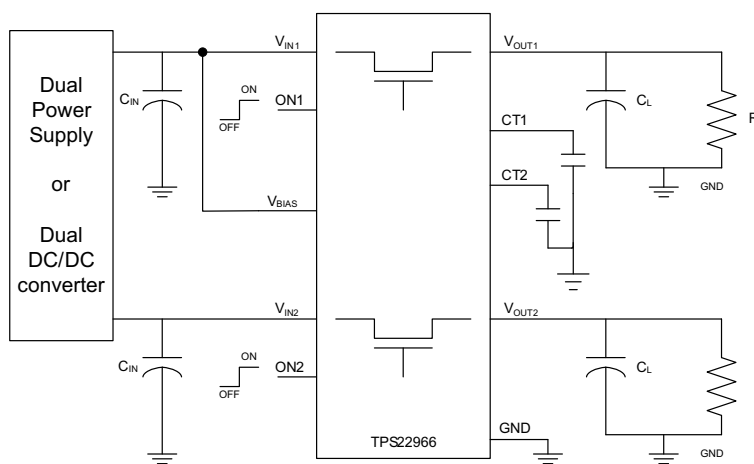


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4 Revision History

Changes from Revision E (February 2015) to Revision F

| | |
|---|----------|
| • Changed (TPS22966 only) to (Optional) in the Features section. | 1 |
|---|----------|

Changes from Revision D (January 2015) to Revision E

| | |
|--|----------|
| • Added temperature operating ranges to Electrical Characteristics ($V_{BIAS} = 5.0\text{ V}$) table. | 5 |
| • Added temperature operating ranges to Electrical Characteristics ($V_{BIAS} = 2.5\text{ V}$) table. | 6 |
| • Updated graphics in the Typical Characteristics section. | 8 |

Changes from Revision C (June 2013) to Revision D

| | |
|--|----------|
| • Added <i>ESD Ratings</i> table, <i>Feature Description</i> section, <i>Device Functional Modes</i> , <i>Application and Implementation</i> section, <i>Power Supply Recommendations</i> section, <i>Layout</i> section, <i>Device and Documentation Support</i> section, and <i>Mechanical, Packaging, and Orderable Information</i> section | 1 |
|--|----------|

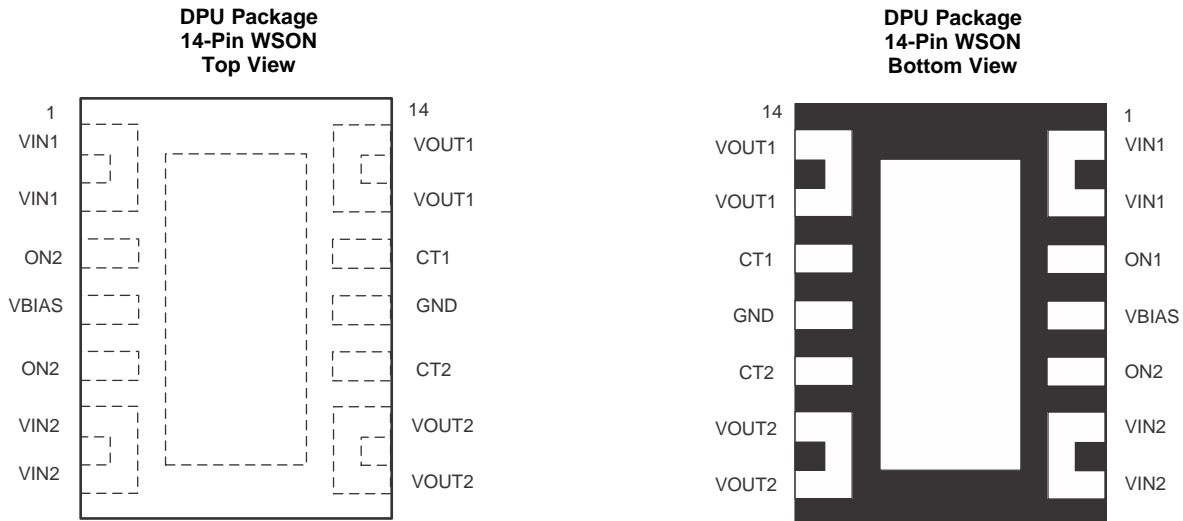
Changes from Revision B (December 2012) to Revision C

| | |
|--|-----------|
| • Added V_{BIAS} to ABSOLUTE MAXIMUM RATINGS table. | 4 |
| • Updated SWITCHING CHARACTERISTIC MEASUREMENT INFORMATION. | 7 |
| • Updated Test Circuit Diagram | 14 |
| • Updated Functional Block Diagram. | 15 |

Changes from Revision A (July 2012) to Revision B

| | |
|---------------------------------------|----------|
| • Updated Application Schematic. | 1 |
|---------------------------------------|----------|

5 Pin Configuration and Functions



Pin Functions

| PIN | | TYPE | DESCRIPTION |
|-----|-------------|------|--|
| NO. | NAME | | |
| 1 | VIN1 | I | Switch 1 input. Recommended voltage range for this pin for optimal R_{ON} performance is 0.8 V to V_{BIAS} . Place an optional decoupling capacitor between this pin and GND for reduce VIN dip during turnon of the channel. See the Application Information section for more information |
| 2 | VIN1 | I | Switch 1 input. Recommended voltage range for this pin for optimal R_{ON} performance is 0.8 V to V_{BIAS} . Place an optional decoupling capacitor between this pin and GND for reduce VIN dip during turnon of the channel. See the Application Information section for more information |
| 3 | ON1 | I | Active high switch 1 control input. Do not leave floating |
| 4 | VBIAS | I | Bias voltage. Power supply to the device. Recommended voltage range for this pin is 2.5 V to 5.5 V. See the Application Information section |
| 5 | ON2 | I | Active high switch 2 control input. Do not leave floating |
| 6 | VIN2 | I | Switch 2 input. Recommended voltage range for this pin for optimal R_{ON} performance is 0.8 V to V_{BIAS} . Place an optional decoupling capacitor between this pin and GND for reduce VIN dip during turnon of the channel. See the Application Information section for more information |
| 7 | VIN2 | I | Switch 2 input. Recommended voltage range for this pin for optimal R_{ON} performance is 0.8 V to V_{BIAS} . Place an optional decoupling capacitor between this pin and GND for reduce VIN dip during turnon of the channel. See the Application Information section for more information |
| 8 | VOUT2 | O | Switch 2 output |
| 9 | VOUT2 | O | Switch 2 output |
| 10 | CT2 | O | Switch 2 slew rate control. Can be left floating. Capacitor used on this pin must be rated for a minimum of 25 V for desired rise time performance |
| 11 | GND | — | Ground |
| 12 | CT1 | O | Switch 1 slew rate control. Can be left floating. Capacitor used on this pin must be rated for a minimum of 25 V for desired rise time performance |
| 13 | VOUT1 | O | Switch 1 output |
| 14 | VOUT1 | O | Switch 1 output |
| — | Thermal Pad | — | Thermal pad (exposed center pad) to alleviate thermal stress. Tie to GND. See the Layout section for layout guidelines |

6 Specifications

6.1 Absolute Maximum Ratings

Over operating free-air temperature range (unless otherwise noted)⁽¹⁾

| | MIN | MAX | UNIT ⁽²⁾ |
|--|------|-----|---------------------|
| V _{IN1,2} Input voltage | –0.3 | 6 | V |
| V _{OUT1,2} Output voltage | –0.3 | 6 | V |
| V _{ON1,2} ON-pin voltage | –0.3 | 6 | V |
| V _{BIAS} V _{BIAS} voltage | –0.3 | 6 | V |
| I _{MAX} Maximum continuous switch current per channel | | 6 | A |
| I _{PLS} Maximum pulsed switch current per channel, pulse <300 μs, 2% duty cycle | | 8 | A |
| T _J Maximum junction temperature | | 125 | °C |
| T _{LEAD} Maximum lead temperature (10-s soldering time) | | 300 | °C |
| T _{stg} Storage temperature | –65 | 150 | °C |

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltage values are with respect to network ground terminal.

6.2 ESD Ratings

| | VALUE | UNIT |
|--|--|-------|
| V _(ESD) Electrostatic discharge | Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾ | ±2000 |
| | Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾ | ±1000 |

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

| | MIN | MAX | UNIT |
|--|------------------------------------|-------------------|------|
| V _{IN1,2} Input voltage | 0.8 | V _{BIAS} | V |
| V _{BIAS} Bias voltage | 2.5 | 5.5 | V |
| V _{ON1,2} ON voltage | 0 | 5.5 | V |
| V _{OUT1,2} Output voltage | | V _{IN} | V |
| V _{IH} High-level input voltage, ON | V _{BIAS} = 2.5 V to 5.5 V | | 1.2 |
| V _{IL} Low-level input voltage, ON | V _{BIAS} = 2.5 V to 5.5 V | | 0 |
| C _{IN1,2} Input capacitor | | 1 ⁽¹⁾ | μF |
| T _A Operating free-air temperature ⁽²⁾ | –40 | 105 | °C |

- (1) See the [Input Capacitor \(Optional\)](#) section.
- (2) In applications where high power dissipation and/or poor package thermal resistance is present, the maximum ambient temperature may have to be derated. Maximum ambient temperature [T_{A(max)}] is dependent on the maximum operating junction temperature [T_{J(max)}], the maximum power dissipation of the device in the application [P_{D(max)}], and the junction-to-ambient thermal resistance of the part-package in the application (θ_{JA}), as given by the following equation: T_{A(max)} = T_{J(max)} – (θ_{JA} × P_{D(max)}).

6.4 Thermal Information

| THERMAL METRIC ⁽¹⁾ | | TPS22966 | UNIT |
|-------------------------------|--|------------|------|
| | | DPU (WSON) | |
| | | 14 PINS | |
| R _{θJA} | Junction-to-ambient thermal resistance | 52.3 | °C/W |
| R _{θJC(top)} | Junction-to-case (top) thermal resistance | 45.9 | °C/W |
| R _{θJB} | Junction-to-board thermal resistance | 11.5 | °C/W |
| ψ _{JT} | Junction-to-top characterization parameter | 0.8 | °C/W |

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

Thermal Information (continued)

| THERMAL METRIC ⁽¹⁾ | | TPS22966 | UNIT |
|-------------------------------|--|------------|------|
| | | DPU (WSON) | |
| | | 14 PINS | |
| ψ_{JB} | Junction-to-board characterization parameter | 11.4 | °C/W |
| $R_{\theta JC(bot)}$ | Junction-to-case (bottom) thermal resistance | 6.9 | °C/W |

6.5 Electrical Characteristics— $V_{BIAS} = 5\text{ V}$

Unless otherwise noted, the specification in the following table applies where $V_{BIAS} = 5\text{ V}$. Typical values are for $T_A = 25^\circ\text{C}$ (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | T_A | MIN | TYP | MAX | UNIT |
|------------------------------------|--|---|---|------|-----|------------------|
| POWER SUPPLIES AND CURRENTS | | | | | | |
| $I_{IN(VBIAS-ON)}$ | V_{BIAS} quiescent current (both channels) $I_{OUT1} = I_{OUT2} = 0\text{ mA}$, $V_{IN1,2} = V_{ON1,2} = V_{BIAS} = 5\text{ V}$ | -40°C to $+105^\circ\text{C}$ | 80 | 120 | | μA |
| $I_{IN(VBIAS-ON)}$ | V_{BIAS} quiescent current (single channel) $I_{OUT1} = I_{OUT2} = 0\text{ mA}$, $V_{ON2} = 0\text{ V}$ $V_{IN1,2} = V_{ON1} = V_{BIAS} = 5\text{ V}$ | -40°C to $+105^\circ\text{C}$ | 60 | 120 | | μA |
| $I_{IN(VBIAS-OFF)}$ | V_{BIAS} shutdown current $V_{ON1,2} = 0\text{ V}$, $V_{OUT1,2} = 0\text{ V}$ | -40°C to $+105^\circ\text{C}$ | | | 2 | μA |
| $I_{IN(VIN-OFF)}$ | $V_{IN1,2}$ off-state supply current (per channel) $V_{ON1,2} = 0\text{ V}$, $V_{OUT1,2} = 0\text{ V}$ | $V_{IN1,2} = 5\text{ V}$ | -40°C to $+105^\circ\text{C}$ | 0.5 | 8 | μA |
| | | $V_{IN1,2} = 3.3\text{ V}$ | -40°C to $+105^\circ\text{C}$ | 0.1 | 3 | |
| | | $V_{IN1,2} = 1.8\text{ V}$ | -40°C to $+105^\circ\text{C}$ | 0.07 | 2 | |
| | | $V_{IN1,2} = 0.8\text{ V}$ | -40°C to $+105^\circ\text{C}$ | 0.04 | 1 | |
| I_{ON} | ON pin input leakage current $V_{ON} = 5.5\text{ V}$ | -40°C to $+105^\circ\text{C}$ | | | 1 | μA |
| RESISTANCE CHARACTERISTICS | | | | | | |
| R_{ON} | ON-state resistance (per channel) $I_{OUT} = -200\text{ mA}$, $V_{BIAS} = 5\text{ V}$ | $V_{IN} = 5\text{ V}$ | 25°C | 16 | 19 | $\text{m}\Omega$ |
| | | | -40°C to $+85^\circ\text{C}$ | | 21 | |
| | | | -40°C to $+105^\circ\text{C}$ | | 23 | |
| | | $V_{IN} = 3.3\text{ V}$ | 25°C | 16 | 19 | |
| | | | -40°C to $+85^\circ\text{C}$ | | 21 | |
| | | | -40°C to $+105^\circ\text{C}$ | | 23 | |
| | | $V_{IN} = 1.8\text{ V}$ | 25°C | 16 | 19 | |
| | | | -40°C to $+85^\circ\text{C}$ | | 21 | |
| | | | -40°C to $+105^\circ\text{C}$ | | 23 | |
| | | $V_{IN} = 1.5\text{ V}$ | 25°C | 16 | 19 | |
| | | | -40°C to $+85^\circ\text{C}$ | | 21 | |
| | | | -40°C to $+105^\circ\text{C}$ | | 23 | |
| | | $V_{IN} = 1.2\text{ V}$ | 25°C | 16 | 19 | |
| | | | -40°C to $+85^\circ\text{C}$ | | 21 | |
| | | | -40°C to $+105^\circ\text{C}$ | | 23 | |
| | | $V_{IN} = 0.8\text{ V}$ | 25°C | 16 | 19 | |
| | | | -40°C to $+85^\circ\text{C}$ | | 21 | |
| | | | -40°C to $+105^\circ\text{C}$ | | 23 | |
| R_{PD} | Output pulldown resistance $V_{IN} = 5\text{ V}$, $V_{ON} = 0\text{ V}$, $I_{OUT} = 15\text{ mA}$ | -40°C to $+85^\circ\text{C}$ | 220 | 300 | | Ω |
| | | -40°C to $+105^\circ\text{C}$ | | 330 | | |

6.6 Electrical Characteristics— $V_{BIAS} = 2.5\text{ V}$

Unless otherwise noted, the specification in the following table applies where $V_{BIAS} = 2.5\text{ V}$. Typical values are for $T_A = 25^\circ\text{C}$ (unless otherwise noted)

| PARAMETER | | TEST CONDITIONS | T_A | MIN | TYP | MAX | UNIT |
|------------------------------------|--|---|---|---|-----|-----|------------------|
| POWER SUPPLIES AND CURRENTS | | | | | | | |
| $I_{IN(VBIAS-ON)}$ | V_{BIAS} quiescent current (both channels) | $I_{OUT1} = I_{OUT2} = 0\text{ mA}$, $V_{IN1,2} = V_{ON1,2} = V_{BIAS} = 2.5\text{ V}$ | -40°C to $+85^\circ\text{C}$ | 32 | 37 | | μA |
| | | | -40°C to $+105^\circ\text{C}$ | | 40 | | |
| $I_{IN(VBIAS-ON)}$ | V_{BIAS} quiescent current (single channel) | $I_{OUT1} = I_{OUT2} = 0\text{ mA}$, $V_{ON2} = 0\text{ V}$ $V_{IN1,2} = V_{ON1} = V_{BIAS} = 2.5\text{ V}$ | -40°C to $+105^\circ\text{C}$ | 23 | 40 | | μA |
| $I_{IN(VBIAS-OFF)}$ | V_{BIAS} shutdown current | $V_{ON1,2} = 0\text{ V}$, $V_{OUT1,2} = 0\text{ V}$ | -40°C to $+105^\circ\text{C}$ | | | 2 | μA |
| $I_{IN(VIN-OFF)}$ | $V_{IN1,2}$ off-state supply current (per channel) | $V_{ON1,2} = 0\text{ V}$, $V_{OUT1,2} = 0\text{ V}$ | $V_{IN1,2} = 2.5\text{ V}$ -40°C to $+105^\circ\text{C}$ | 0.13 | 3 | | μA |
| | | | $V_{IN1,2} = 1.8\text{ V}$ -40°C to $+105^\circ\text{C}$ | 0.07 | 2 | | |
| | | | $V_{IN1,2} = 1.2\text{ V}$ -40°C to $+105^\circ\text{C}$ | 0.05 | 2 | | |
| | | | $V_{IN1,2} = 0.8\text{ V}$ -40°C to $+105^\circ\text{C}$ | 0.04 | 1 | | |
| I_{ON} | ON pin input leakage current | $V_{ON} = 5.5\text{ V}$ | -40°C to $+105^\circ\text{C}$ | | | 1 | μA |
| RESISTANCE CHARACTERISTICS | | | | | | | |
| R_{ON} | ON-state resistance | $I_{OUT} = -200\text{ mA}$, $V_{BIAS} = 2.5\text{ V}$ | $V_{IN} = 2.5\text{ V}$ | 25 $^\circ\text{C}$ | 21 | 24 | $\text{m}\Omega$ |
| | | | | -40°C to $+85^\circ\text{C}$ | | 27 | |
| | | | | -40°C to $+105^\circ\text{C}$ | | 29 | |
| | | | $V_{IN} = 1.8\text{ V}$ | 25 $^\circ\text{C}$ | 19 | 22 | |
| | | | | -40°C to $+85^\circ\text{C}$ | | 25 | |
| | | | | -40°C to $+105^\circ\text{C}$ | | 27 | |
| | | | $V_{IN} = 1.5\text{ V}$ | 25 $^\circ\text{C}$ | 18 | 21 | |
| | | | | -40°C to $+85^\circ\text{C}$ | | 24 | |
| | | | | -40°C to $+105^\circ\text{C}$ | | 26 | |
| | | | $V_{IN} = 1.2\text{ V}$ | 25 $^\circ\text{C}$ | 18 | 21 | |
| | | | | -40°C to $+85^\circ\text{C}$ | | 24 | |
| | | | | -40°C to $+105^\circ\text{C}$ | | 26 | |
| | | | $V_{IN} = 0.8\text{ V}$ | 25 $^\circ\text{C}$ | 17 | 20 | |
| | | | | -40°C to $+85^\circ\text{C}$ | | 23 | |
| | | | | -40°C to $+105^\circ\text{C}$ | | 25 | |
| R_{PD} | Output pulldown resistance | $V_{IN} = 2.5\text{ V}$, $V_{ON} = 0\text{ V}$, $I_{OUT} = 1\text{ mA}$ | -40°C to $+85^\circ\text{C}$ | 260 | 300 | | Ω |
| | | | -40°C to $+105^\circ\text{C}$ | | 330 | | |

6.7 Switching Characteristics

| PARAMETER | | TEST CONDITION | MIN | TYP | MAX | UNIT |
|---|----------------------------|--|-----|------|-----|------|
| V _{IN} = V _{ON} = V _{BIAS} = 5 V, T _A = 25°C (unless otherwise noted) | | | | | | |
| t _{ON} | Turnon time | R _L = 10 Ω, C _L = 0.1 μF, C _T = 1000 pF | | 1310 | | μs |
| t _{OFF} | Turnoff time | R _L = 10 Ω, C _L = 0.1 μF, C _T = 1000 pF | | 6 | | |
| t _R | V _{OUT} rise time | R _L = 10 Ω, C _L = 0.1 μF, C _T = 1000 pF | | 1720 | | |
| t _F | V _{OUT} fall time | R _L = 10 Ω, C _L = 0.1 μF, C _T = 1000 pF | | 2 | | |
| t _D | ON delay time | R _L = 10 Ω, C _L = 0.1 μF, C _T = 1000 pF | | 460 | | |
| V _{IN} = 0.8 V, V _{ON} = V _{BIAS} = 5 V, T _A = 25°C (unless otherwise noted) | | | | | | |
| t _{ON} | Turnon time | R _L = 10 Ω, C _L = 0.1 μF, C _T = 1000 pF | | 550 | | μs |
| t _{OFF} | Turnoff time | R _L = 10 Ω, C _L = 0.1 μF, C _T = 1000 pF | | 170 | | |
| t _R | V _{OUT} rise time | R _L = 10 Ω, C _L = 0.1 μF, C _T = 1000 pF | | 325 | | |
| t _F | V _{OUT} fall time | R _L = 10 Ω, C _L = 0.1 μF, C _T = 1000 pF | | 16 | | |
| t _D | ON delay time | R _L = 10 Ω, C _L = 0.1 μF, C _T = 1000 pF | | 400 | | |
| V _{IN} = 2.5 V, V _{ON} = 5 V, V _{BIAS} = 2.5 V, T _A = 25°C (unless otherwise noted) | | | | | | |
| t _{ON} | Turnon time | R _L = 10 Ω, C _L = 0.1 μF, C _T = 1000 pF | | 2050 | | μs |
| t _{OFF} | Turnoff time | R _L = 10 Ω, C _L = 0.1 μF, C _T = 1000 pF | | 5 | | |
| t _R | V _{OUT} rise time | R _L = 10 Ω, C _L = 0.1 μF, C _T = 1000 pF | | 2275 | | |
| t _F | V _{OUT} fall time | R _L = 10 Ω, C _L = 0.1 μF, C _T = 1000 pF | | 2.5 | | |
| t _D | ON delay time | R _L = 10 Ω, C _L = 0.1 μF, C _T = 1000 pF | | 990 | | |
| V _{IN} = 0.8 V, V _{ON} = 5 V, V _{BIAS} = 2.5 V, T _A = 25°C (unless otherwise noted) | | | | | | |
| t _{ON} | Turnon time | R _L = 10 Ω, C _L = 0.1 μF, C _T = 1000 pF | | 1300 | | μs |
| t _{OFF} | Turnoff time | R _L = 10 Ω, C _L = 0.1 μF, C _T = 1000 pF | | 130 | | |
| t _R | V _{OUT} rise time | R _L = 10 Ω, C _L = 0.1 μF, C _T = 1000 pF | | 875 | | |
| t _F | V _{OUT} fall time | R _L = 10 Ω, C _L = 0.1 μF, C _T = 1000 pF | | 16 | | |
| t _D | ON delay time | R _L = 10 Ω, C _L = 0.1 μF, C _T = 1000 pF | | 870 | | |

6.8 Typical DC Characteristics

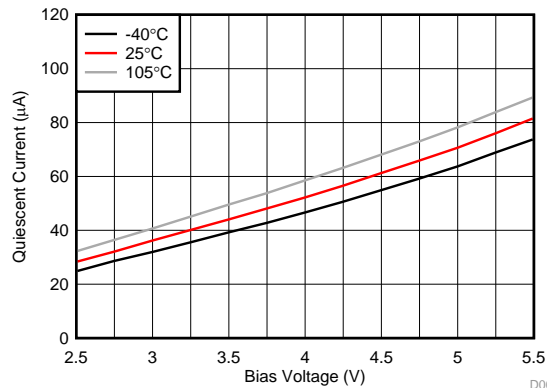

 $V_{IN1} = V_{IN2} = V_{BIAS}$ $V_{ON1} = V_{ON2} = 5\text{ V}$ $V_{OUT} = \text{Open}$

Figure 1. Quiescent Current vs Bias Voltage Both Channels

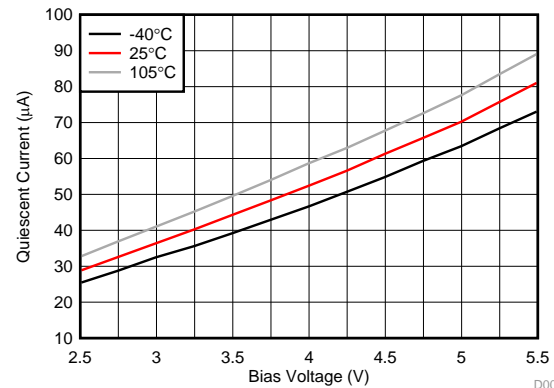

 $V_{IN1} = V_{IN2} = V_{BIAS}$ $V_{ON1} = V_{ON2} = 5\text{ V}$ $V_{OUT} = \text{Open}$

Figure 2. Quiescent Current vs Bias Voltage Single Channel

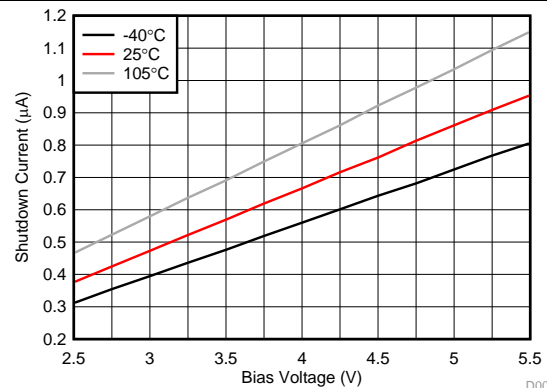

 $V_{IN1} = V_{IN2} = V_{BIAS}$ $V_{ON1} = V_{ON2} = 0\text{ V}$ $V_{OUT} = 0\text{ V}$

Figure 3. Shutdown Current vs Bias Voltage Both Channels

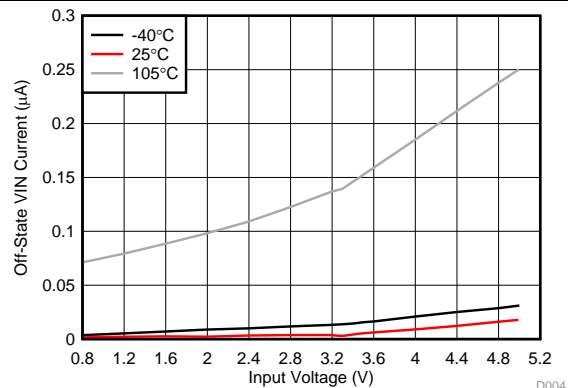

 $V_{BIAS} = 5\text{ V}$ $V_{ON} = 0\text{ V}$ $V_{OUT} = 0\text{ V}$

Figure 4. Off-State VIN Current vs Input Voltage Single Channel

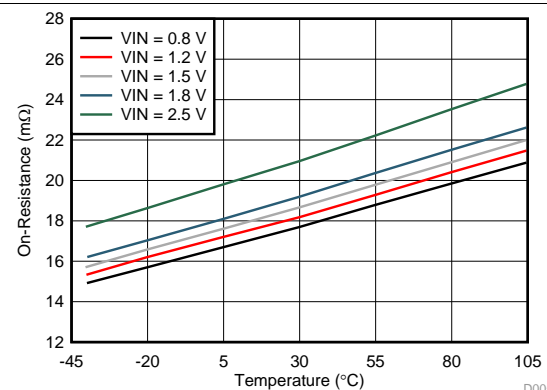

 $V_{BIAS} = 2.5\text{ V}$ $I_{OUT} = -200\text{ mA}$

Figure 5. On-Resistance vs Temperature Single Channel

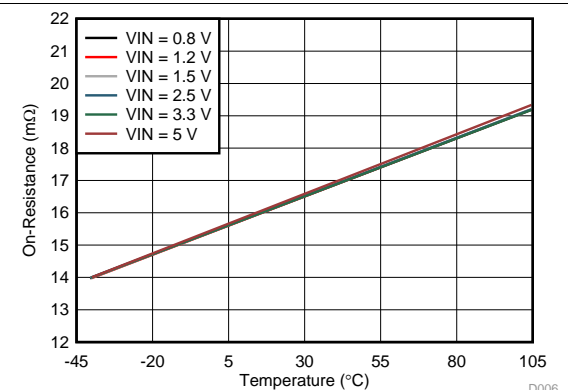
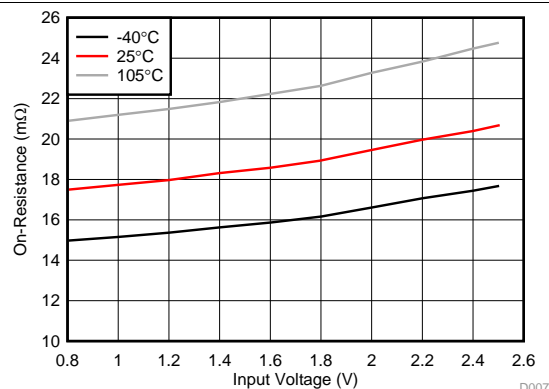

 $V_{BIAS} = 5\text{ V}$ $I_{OUT} = -200\text{ mA}$

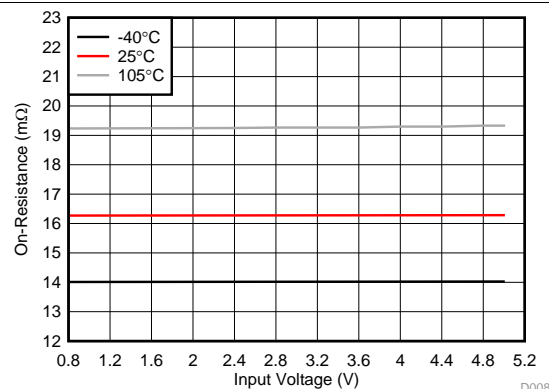
Figure 6. On-Resistance vs Temperature Single Channel

Typical DC Characteristics (continued)



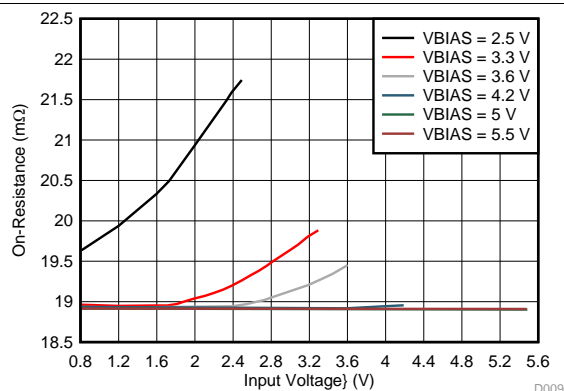
$V_{BIAS} = 2.5\text{ V}$ $I_{OUT} = -200\text{ mA}$

**Figure 7. On-Resistance vs Input Voltage
Single Channel**



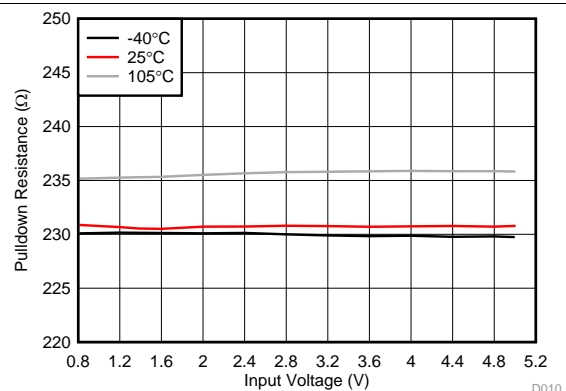
$V_{BIAS} = 5\text{ V}$ $I_{OUT} = -200\text{ mA}$

**Figure 8. On-Resistance vs Input Voltage
Single Channel**



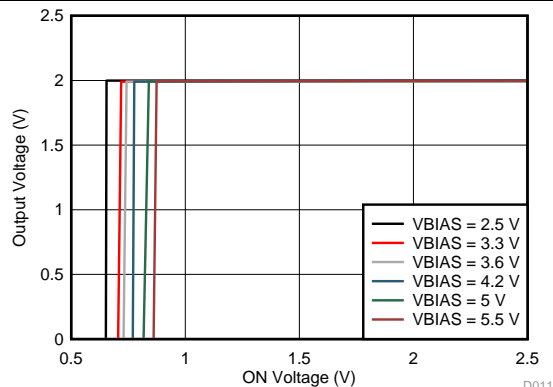
$T_A = 25^\circ\text{C}$

**Figure 9. On-Resistance vs Input Voltage
Single Channel**



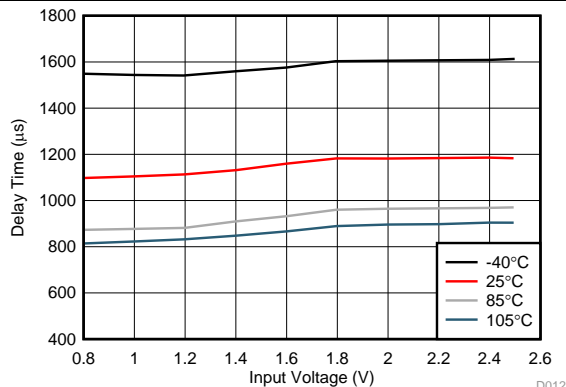
$V_{BIAS} = 5\text{ V}$ $I_{OUT} = 1\text{ mA}$ $V_{ON} = 0\text{ V}$

**Figure 10. Pulldown Resistance vs Input Voltage
Single Channel**



$T_A = 25^\circ\text{C}$

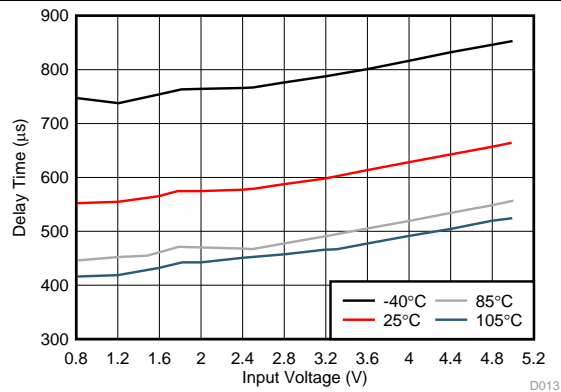
**Figure 11. Output Voltage vs ON Voltage
Single Channel**



$V_{BIAS} = 2.5\text{ V}$ $C_T = 1\text{ nF}$

Figure 12. Delay Time vs Input Voltage

Typical DC Characteristics (continued)

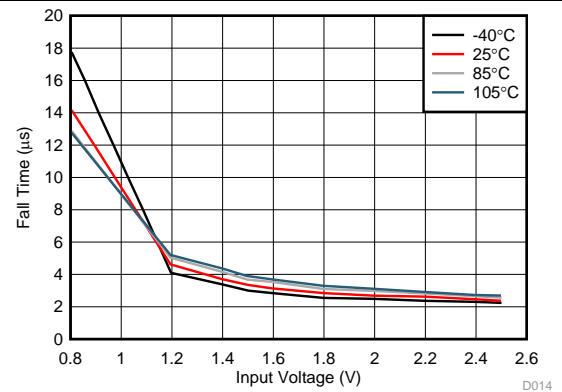


$V_{BIAS} = 5\text{ V}$

$CT = 1\text{ nF}$

D013

Figure 13. Delay Time vs Input Voltage

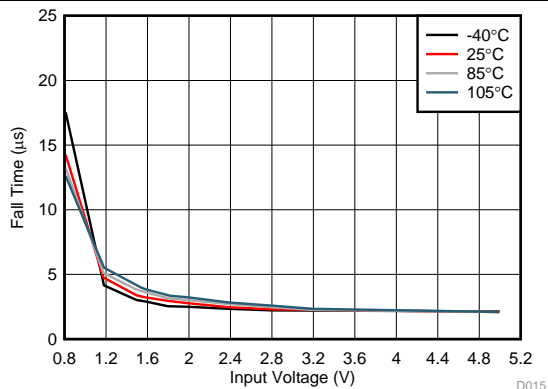


$V_{BIAS} = 2.5\text{ V}$

$CT = 1\text{ nF}$

D014

Figure 14. Fall Time vs Input Voltage

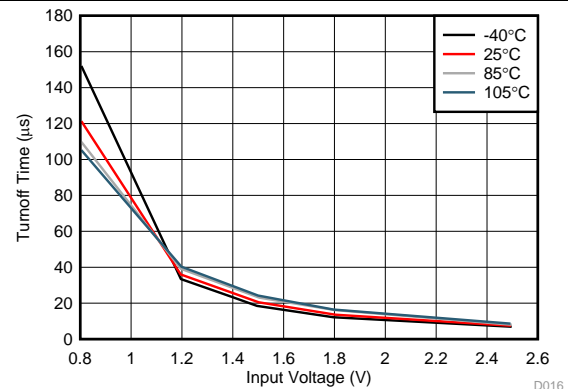


$V_{BIAS} = 5\text{ V}$

$CT = 1\text{ nF}$

D015

Figure 15. Fall Time vs Input Voltage

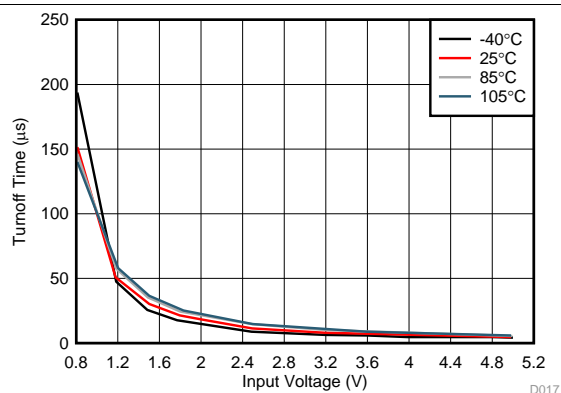


$V_{BIAS} = 2.5\text{ V}$

$CT = 1\text{ nF}$

D016

Figure 16. Turnoff Time vs Input Voltage

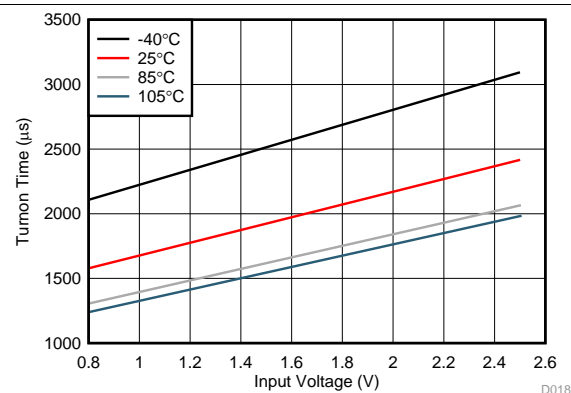


$V_{BIAS} = 5\text{ V}$

$CT = 1\text{ nF}$

D017

Figure 17. Turnoff Time vs Input Voltage



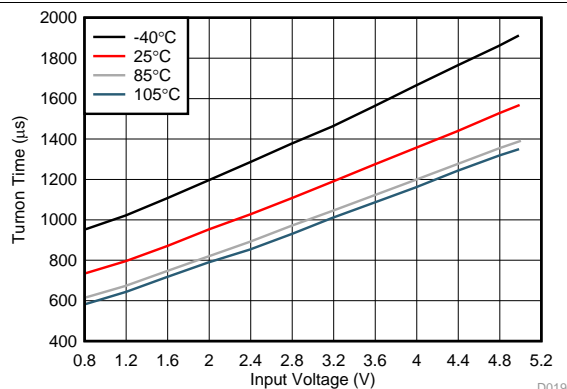
$V_{BIAS} = 2.5\text{ V}$

$CT = 1\text{ nF}$

D018

Figure 18. Turnon Time vs Input Voltage

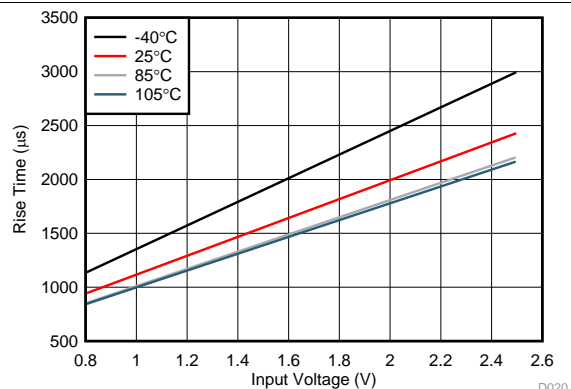
Typical DC Characteristics (continued)



$V_{BIAS} = 5\text{ V}$

$CT = 1\text{ nF}$

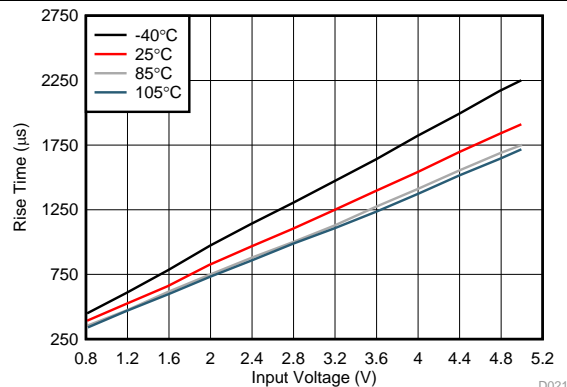
Figure 19. Turnon Time vs Input Voltage



$V_{BIAS} = 2.5\text{ V}$

$CT = 1\text{ nF}$

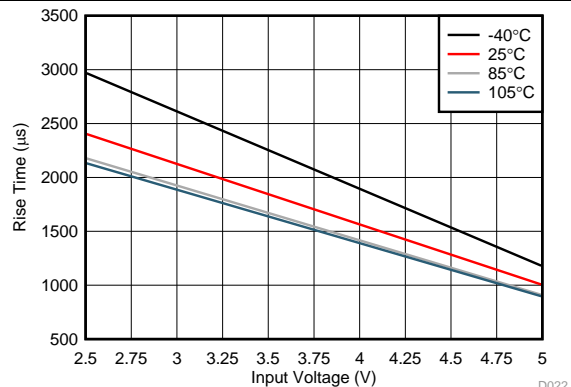
Figure 20. Rise Time vs Input Voltage



$V_{BIAS} = 5\text{ V}$

$CT = 1\text{ nF}$

Figure 21. Rise Time vs Input Voltage ($V_{BIAS} = 5\text{ V}$, $CT = 1\text{ nF}$)

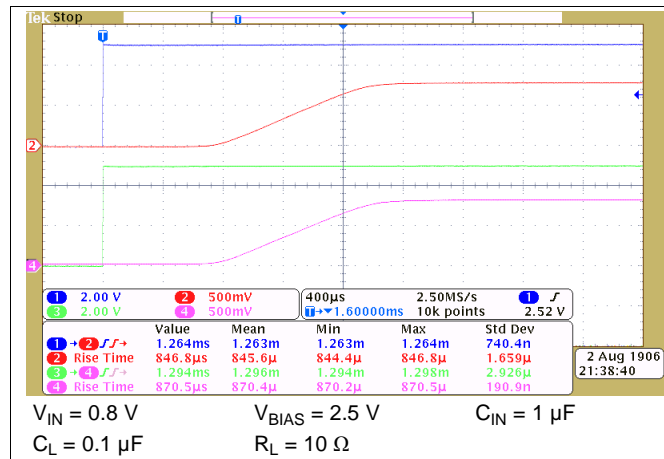
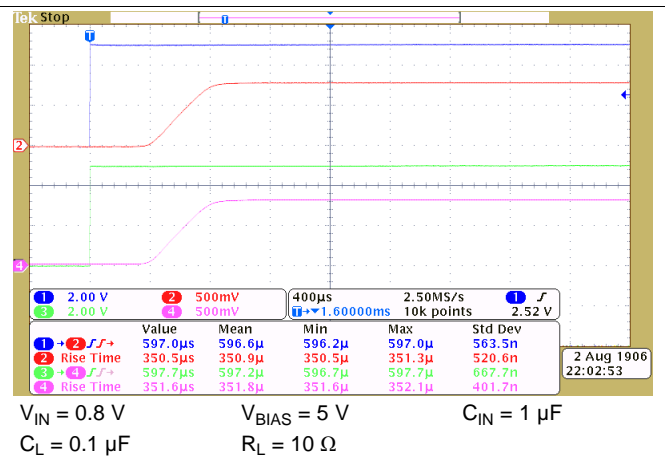
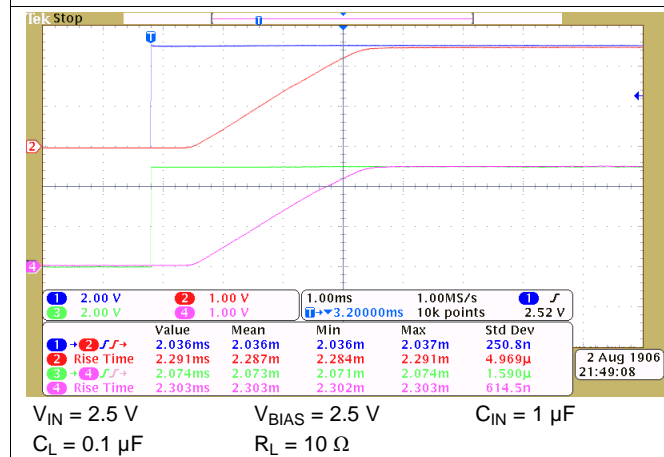
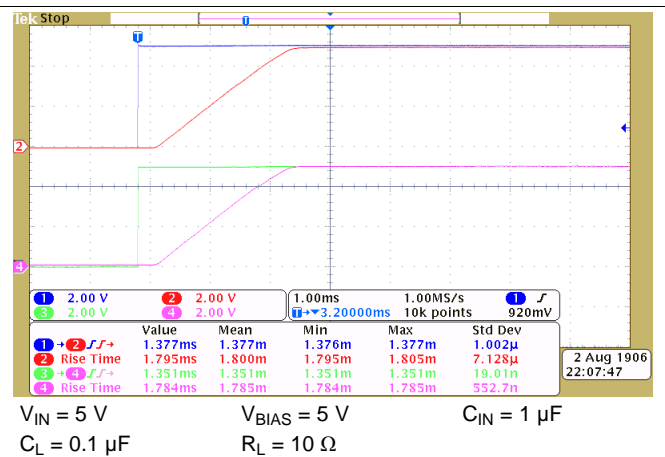
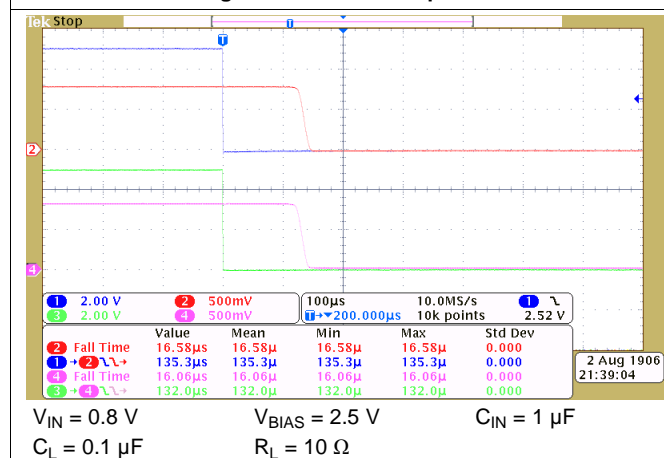
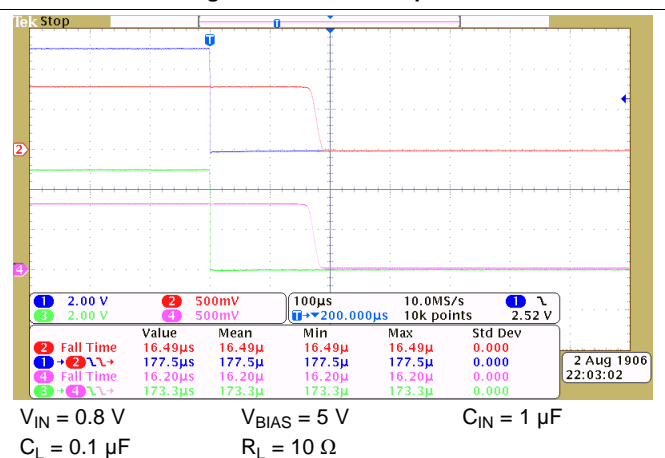


$V_{IN} = 2.5\text{ V}$

$CT = 1\text{ nF}$

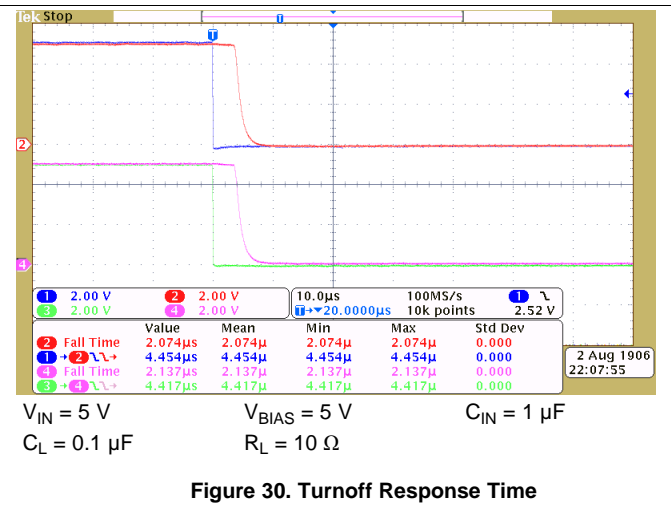
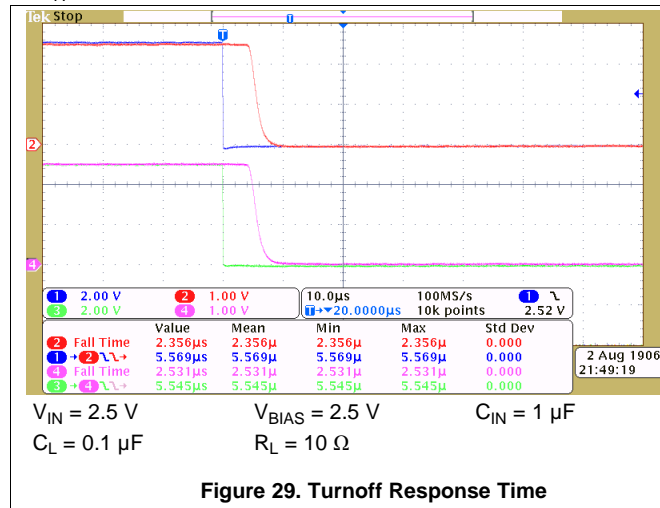
Figure 22. Rise Time vs Bias Voltage

6.9 Typical AC Characteristics

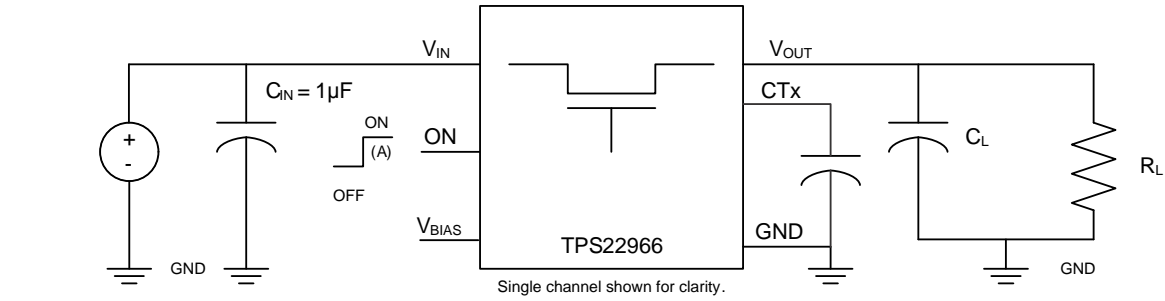
At $T_A = 25^\circ\text{C}$, $C_T = 1\text{ nF}$

Figure 23. Turnon Response Time

Figure 24. Turnon Response Time

Figure 25. Turnon Response Time

Figure 26. Turnon Response Time

Figure 27. Turnoff Response Time

Figure 28. Turnoff Response Time

Typical AC Characteristics (continued)

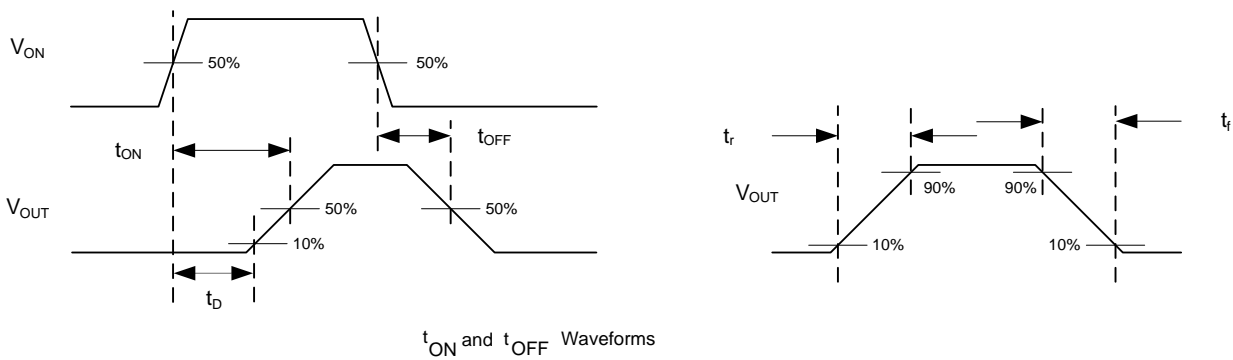
At $T_A = 25^\circ\text{C}$, $C_T = 1\text{ nF}$



7 Parameter Measurement Information



Test Circuit



(A) Rise and fall times of the control signal is 100 ns.

Figure 31. Test Circuit and t_{ON} - t_{OFF} Waveforms

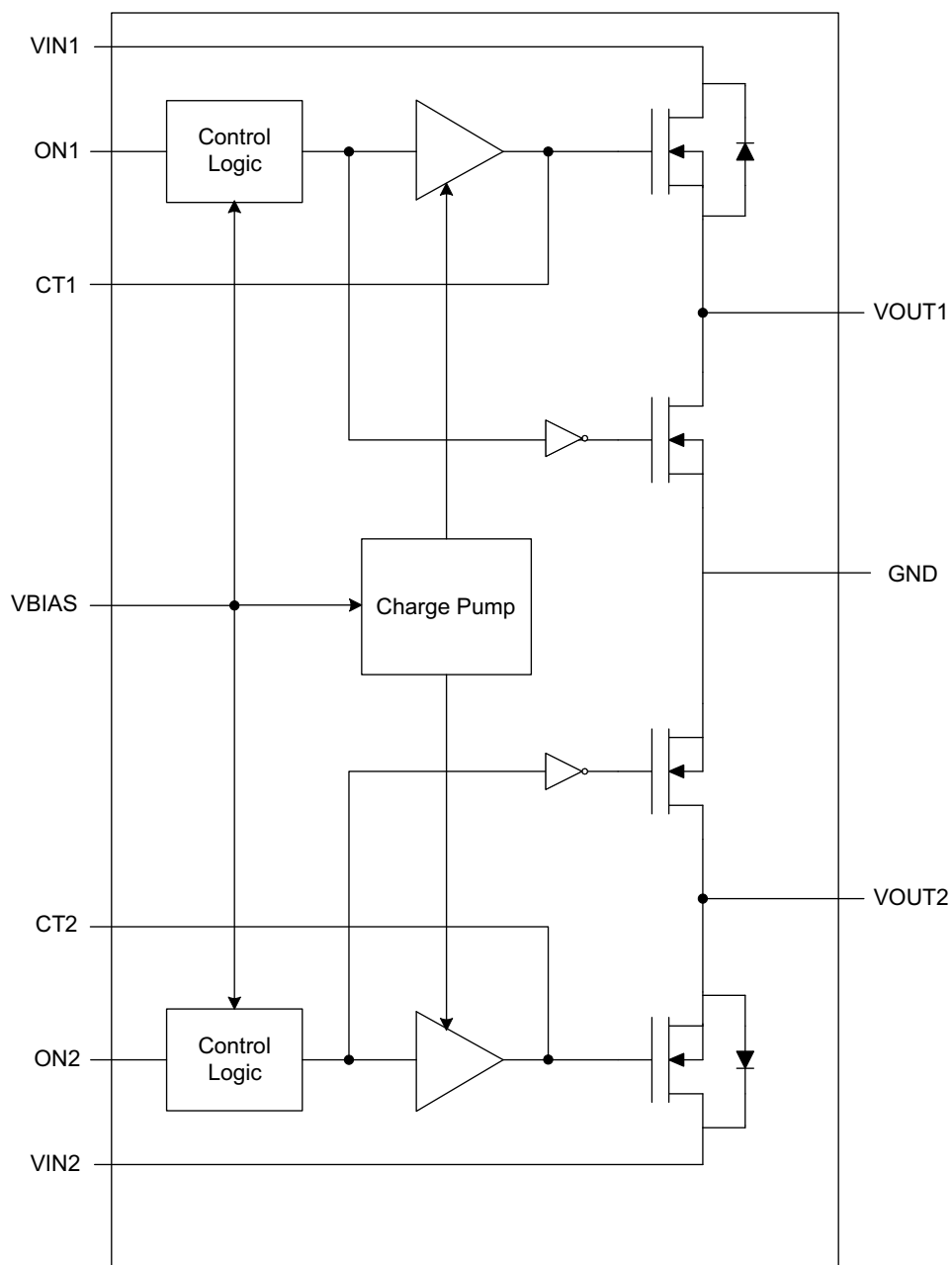
8 Detailed Description

8.1 Overview

The TPS22966 device is a dual-channel, 6-A load switch in a 14-terminal SON package. To reduce the voltage drop in high current rails, the device implements an low resistance N-channel MOSFET. The device has a programmable slew rate for applications that require specific rise-time.

The device has very low leakage current during off state. This prevents downstream circuits from pulling high standby current from the supply. Integrated control logic, driver, power supply, and output discharge FET eliminates the need for any external components, which reduces solution size and bill of materials (BOM) count.

8.2 Functional Block Diagram



8.3 Feature Description

8.3.1 ON and OFF Control

The ON pins control the state of the switch. Asserting ON high enables the switch. ON is active high and has a low threshold, making it capable of interfacing with low-voltage signals. The ON pin is compatible with standard GPIO logic threshold. It can be used with any microcontroller with 1.2-V or higher GPIO voltage. This pin cannot be left floating and must be tied either high or low for proper functionality.

8.3.2 Input Capacitor (Optional)

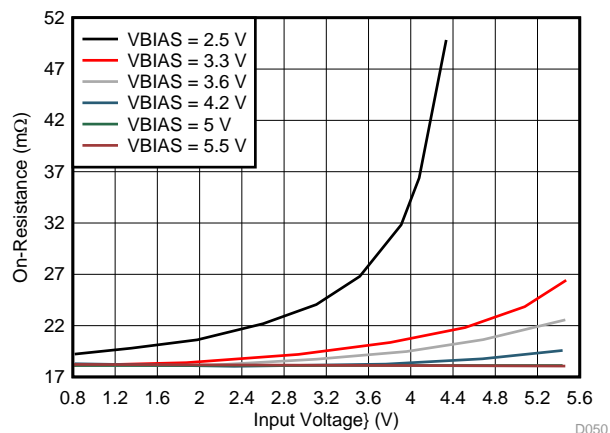
To limit the voltage drop on the input supply caused by transient inrush currents when the switch turns on into a discharged load capacitor, a capacitor needs to be placed between VIN and GND. A 1-μF ceramic capacitor, CIN, placed close to the pins, is usually sufficient. Higher values of CIN can be used to further reduce the voltage drop during high-current application. When switching heavy loads, it is recommended to have an input capacitor about 10 times higher than the output capacitor to avoid excessive voltage drop.

8.3.3 Output Capacitor (Optional)

Due to the integrated body diode in the NMOS switch, a CIN greater than CL is highly recommended. A CL greater than CIN can cause VOUT to exceed VIN when the system supply is removed. This could result in current flow through the body diode from VOUT to VIN. A CIN to CL ratio of 10 to 1 is recommended for minimizing VIN dip caused by inrush currents during startup, however a 10 to 1 ratio for capacitance is not required for proper functionality of the device. A ratio smaller than 10 to 1 (such as 1 to 1) could cause slightly more VIN dip upon turn-on due to inrush currents. This can be mitigated by increasing the capacitance on the CT pin for a longer rise time (see Figure 4).

8.3.4 VIN and VBIAS Voltage Range

For optimal RON performance, make sure VIN ≤ VBIAS. The device is still functional if VIN > VBIAS but it exhibits RON greater than what is listed in the [Electrical Characteristics](#) table. See Figure 32 for an example of a typical device. Notice the increasing RON as VIN exceeds VBIAS voltage. Make sure to never exceed the maximum voltage rating for VIN and VBIAS.



$$V_{IN} > V_{BIAS}$$

$$I_{OUT} = -200 \text{ mA}$$

Figure 32. On-Resistance vs Input Voltage Single Channel

8.4 Device Functional Modes

[Table 1](#) lists the TPS22966 functions.

Table 1. Functions Table

| ONx | VINx to VOUTx | VOUTx to GND |
|-----|---------------|--------------|
| L | Off | On |
| H | On | Off |

9 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

This application demonstrates how the TPS22966 can be used to limit inrush current when powering on downstream modules.

9.2 Typical Application

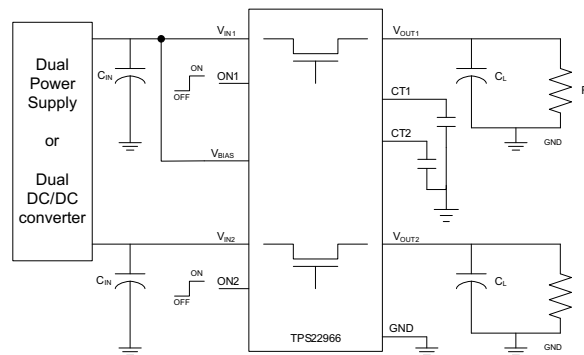


Figure 33. Typical Application Circuit

9.2.1 Design Requirements

Table 2 shows the TPS22966 design parameters.

Table 2. Design Parameters

| DESIGN PARAMETER | VALUE |
|------------------------------------|--------|
| Input voltage | 3.3 V |
| Bias voltage | 5 V |
| Load capacitance (C _L) | 22 μF |
| Maximum acceptable inrush current | 400 mA |

9.2.2 Detailed Design Procedure

When the switch is enabled, the output capacitors must be charged up from 0 V to the set value (3.3 V in this example). This charge arrives in the form of inrush current. Inrush current can be calculated using Equation 1.

$$\text{Inrush Current} = C \times dV/dt$$

where

- C is the output capacitance
- dV is the output voltage
- dt is the rise time

(1)

The TPS22966 offers adjustable rise time for V_{OUT}. This feature allows the user to control the inrush current during turnon. The appropriate rise time can be calculated using Table 2 and Equation 1 as shown in Equation 2.

$$400 \text{ mA} = 22 \text{ μF} \times 3.3 \text{ V}/dt$$

(2)

$$dt = 181.5 \text{ μs}$$

(3)

To ensure an inrush current of less than 400 mA, choose a CT value that yields a rise time of more than 181.5 μ s. See the oscilloscope captures in the [Application Curves](#) section for an example of how the CT capacitor can be used to reduce inrush current.

9.2.2.1 Adjustable Rise Time

A capacitor to GND on the CTx pins sets the slew rate for each channel. To ensure desired performance, a capacitor with a minimum voltage rating of 25 V must be used on the CTx pin. An approximate formula for the relationship between CTx and slew rate is given in [Equation 4](#). [Equation 4](#) accounts for 10% to 90% measurement on V_{OUT} and does **NOT** apply for CTx = 0 pF. (Use [Table 3](#) to determine rise times for when CTx = 0 pF).

$$SR = 0.32 \times CT + 13.7$$

where

- SR is the slew rate (in μ s/V)
 - CT is the capacitance value on the CTx pin (in pF)
 - The units for the constant 13.7 is in μ s/V.
- (4)

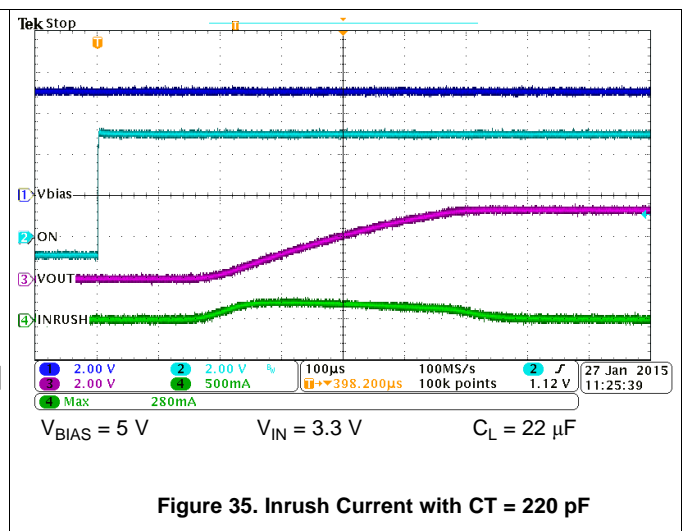
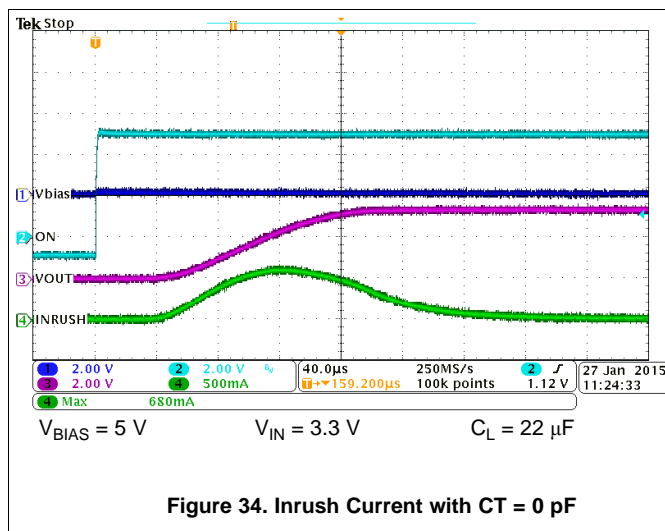
Rise time can be calculated by multiplying the input voltage by the slew rate. [Table 3](#) shows rise time values measured on a typical device. Rise times shown in [Table 3](#) are only valid for the power-up sequence where V_{IN} and V_{BIAS} are already in steady state condition, and the ON pin is asserted high.

Table 3. Rise Time Values

| CTx (pF) | RISE TIME (μ s) 10% - 90%, C _L = 0.1 μ F, C _{IN} = 1 μ F, R _L = 10 Ω | | | | | | |
|----------|---|-------|-------|-------|-------|--------|-------|
| | 5 V | 3.3 V | 1.8 V | 1.5 V | 1.2 V | 1.05 V | 0.8 V |
| 0 | 124 | 88 | 63 | 60 | 53 | 49 | 42 |
| 220 | 481 | 323 | 193 | 166 | 143 | 133 | 109 |
| 470 | 855 | 603 | 348 | 299 | 251 | 228 | 175 |
| 1000 | 1724 | 1185 | 670 | 570 | 469 | 411 | 342 |
| 2200 | 3328 | 2240 | 1308 | 1088 | 893 | 808 | 650 |
| 4700 | 7459 | 4950 | 2820 | 2429 | 1920 | 1748 | 1411 |
| 10000 | 16059 | 10835 | 6040 | 5055 | 4230 | 3770 | 3033 |

(1) TYPICAL VALUES at 25°C, V_{BIAS} = 5 V, 25 V X7R 10% CERAMIC CAP.

9.2.3 Application Curves



10 Power Supply Recommendations

The device is designed to operate from a VBIAS range of 2.5 V to 5.5 V and a VIN range of 0.8 V to VBIAS.

11 Layout

11.1 Layout Guidelines

For best performance, all traces must be as short as possible. To be most effective, the input and output capacitors must be placed close to the device to minimize the effects that parasitic trace inductances may have on normal operation. Using wide traces for VIN, VOUT, and GND helps minimize the parasitic electrical effects along with minimizing the case to ambient thermal impedance.

11.2 Layout Example

Notice the thermal vias located under the exposed thermal pad of the device. This allows for thermal diffusion away from the device.

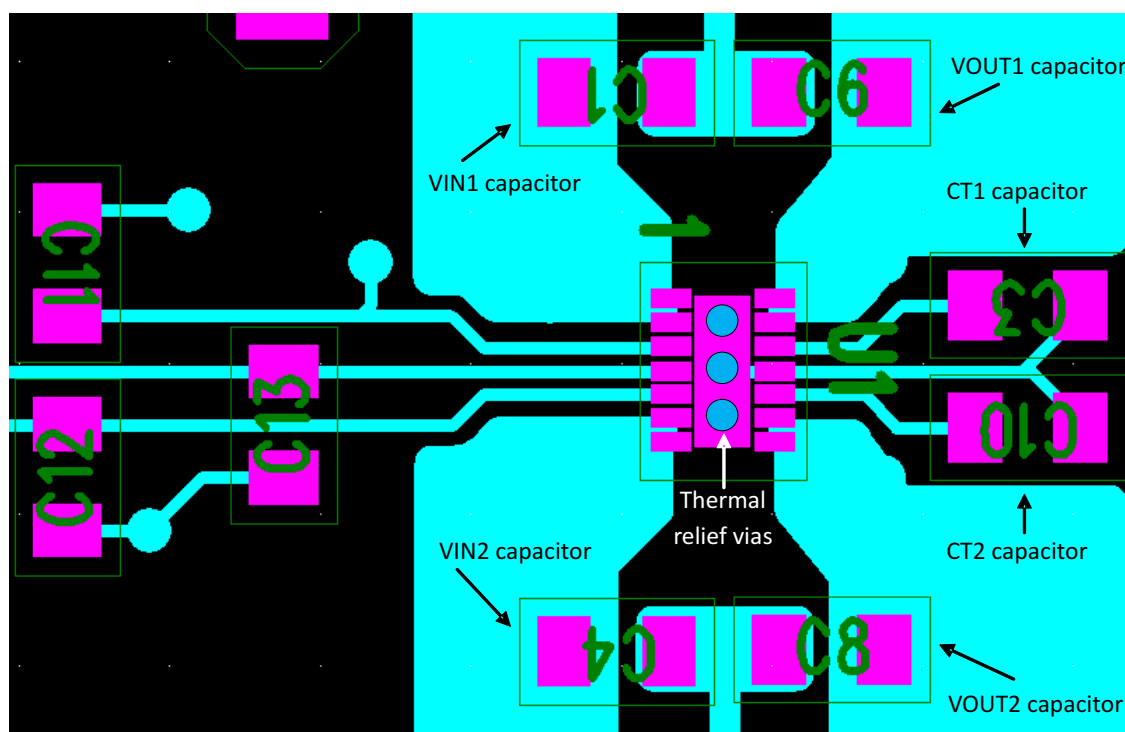


Figure 36. PCB Layout Example

11.3 Thermal Considerations

The maximum IC junction temperature must be restricted to 125°C under normal operating conditions. To calculate the maximum allowable power dissipation, $P_{D(max)}$ for a given output current and ambient temperature, use Equation 5:

$$P_{D(max)} = \frac{T_{J(max)} - T_A}{\theta_{JA}}$$

where

- $P_{D(max)}$ is the maximum allowable power dissipation
- $T_{J(max)}$ is the maximum allowable junction temperature (125°C for the TPS22966)
- T_A is the ambient temperature of the device

Thermal Considerations (continued)

- θ_{JA} is the junction to air thermal impedance. See the [Thermal Information](#) section. This parameter is highly dependent upon board layout. (5)

12 Device and Documentation Support

12.1 Documentation Support

12.1.1 Related Documentation

For related documentation see the following:

- *TPS22966 Dual Channel Load Switch in Parallel Configuration*, [SLVA585A](#)
- *Basics of Load Switches*, [SLVA652](#)
- *Managing Inrush Current*, [SLVA670A](#)
- *Quiescent Current vs Shutdown Current for Load Switch Power Consumption*, [SLVA757](#)
- *Using the TPS22966EVM-007*, [SLVU757A](#)
- *Load Switch Thermal Considerations*, [SLVUA74](#)

12.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on [ti.com](#). In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

12.3 Trademarks

Ultrabook is a trademark of Intel.

All other trademarks are the property of their respective owners.

12.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

12.5 Glossary

[SLYZ022](#) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

| Orderable Device | Status (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan (2) | Lead finish/ Ball material (6) | MSL Peak Temp (3) | Op Temp (°C) | Device Marking (4/5) | Samples |
|------------------|---------------|--------------|--------------------|------|----------------|-----------------|--------------------------------------|----------------------|--------------|-------------------------|-------------------------|
| TPS22966DPUR | ACTIVE | WSO | DPU | 14 | 3000 | RoHS & Green | NIPDAU | Level-2-260C-1 YEAR | -40 to 105 | RB966 | Samples |
| TPS22966DPUT | ACTIVE | WSO | DPU | 14 | 250 | RoHS & Green | NIPDAU | Level-2-260C-1 YEAR | -40 to 105 | RB966 | Samples |

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBsolete: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF TPS22966 :

- Automotive: [TPS22966-Q1](#)

NOTE: Qualified Version Definitions:

- Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

TAPE AND REEL INFORMATION


*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|--------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| TPS22966DPUR | WSO | DPU | 14 | 3000 | 180.0 | 8.4 | 2.25 | 3.25 | 1.05 | 4.0 | 8.0 | Q1 |
| TPS22966DPUR | WSO | DPU | 14 | 3000 | 180.0 | 8.4 | 2.25 | 3.25 | 1.05 | 4.0 | 8.0 | Q1 |
| TPS22966DPUT | WSO | DPU | 14 | 250 | 180.0 | 8.4 | 2.25 | 3.25 | 1.05 | 4.0 | 8.0 | Q1 |

TAPE AND REEL BOX DIMENSIONS

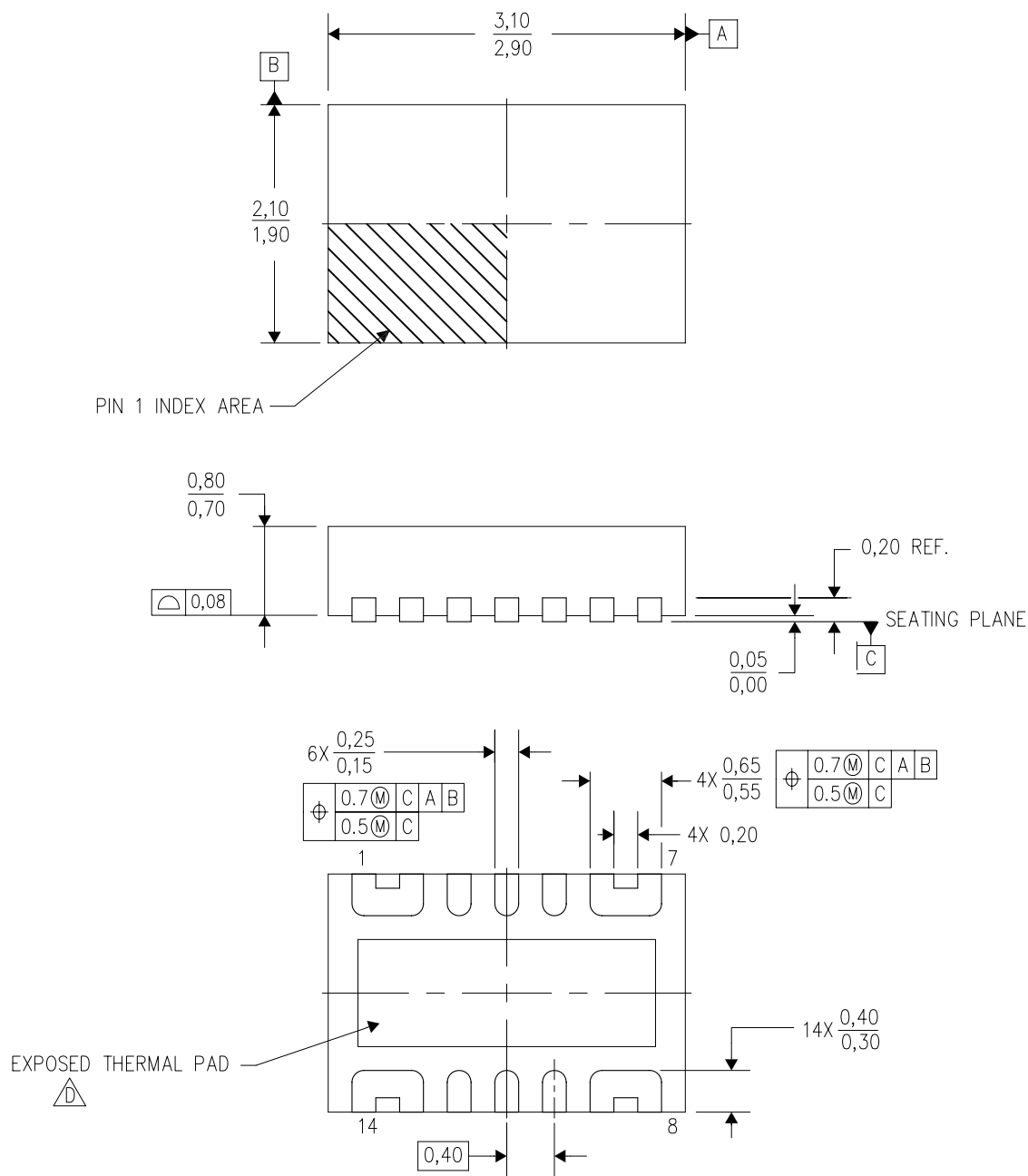


*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
|--------------|--------------|-----------------|------|------|-------------|------------|-------------|
| TPS22966DPUR | WSN | DPU | 14 | 3000 | 210.0 | 185.0 | 35.0 |
| TPS22966DPUR | WSN | DPU | 14 | 3000 | 210.0 | 185.0 | 35.0 |
| TPS22966DPUT | WSN | DPU | 14 | 250 | 210.0 | 185.0 | 35.0 |

DPU (R-PWSON-N14)

PLASTIC SMALL OUTLINE NO-LEAD



4211321/B 11/10

- NOTES:
- | | |
|-----------|---|
| A. | All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994. |
| B. | This drawing is subject to change without notice. |
| C. | Small Outline No-Lead (SON) package configuration. |
| D. | The package thermal pad must be soldered to the board for thermal and mechanical performance. |
| | See the Product Data Sheet for details regarding the exposed thermal pad dimensions. |
| E. | This package is Pb-free. |

THERMAL PAD MECHANICAL DATA

DPU (R-PWSON-N14)

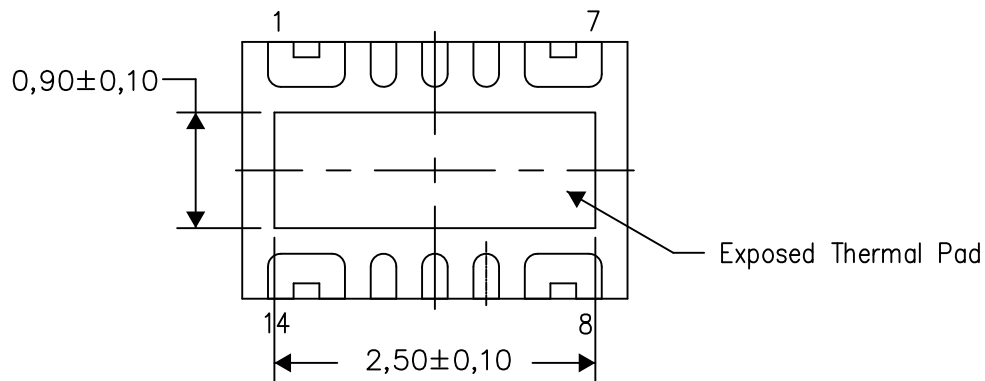
PLASTIC SMALL OUTLINE NO-LEAD

THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



Bottom View

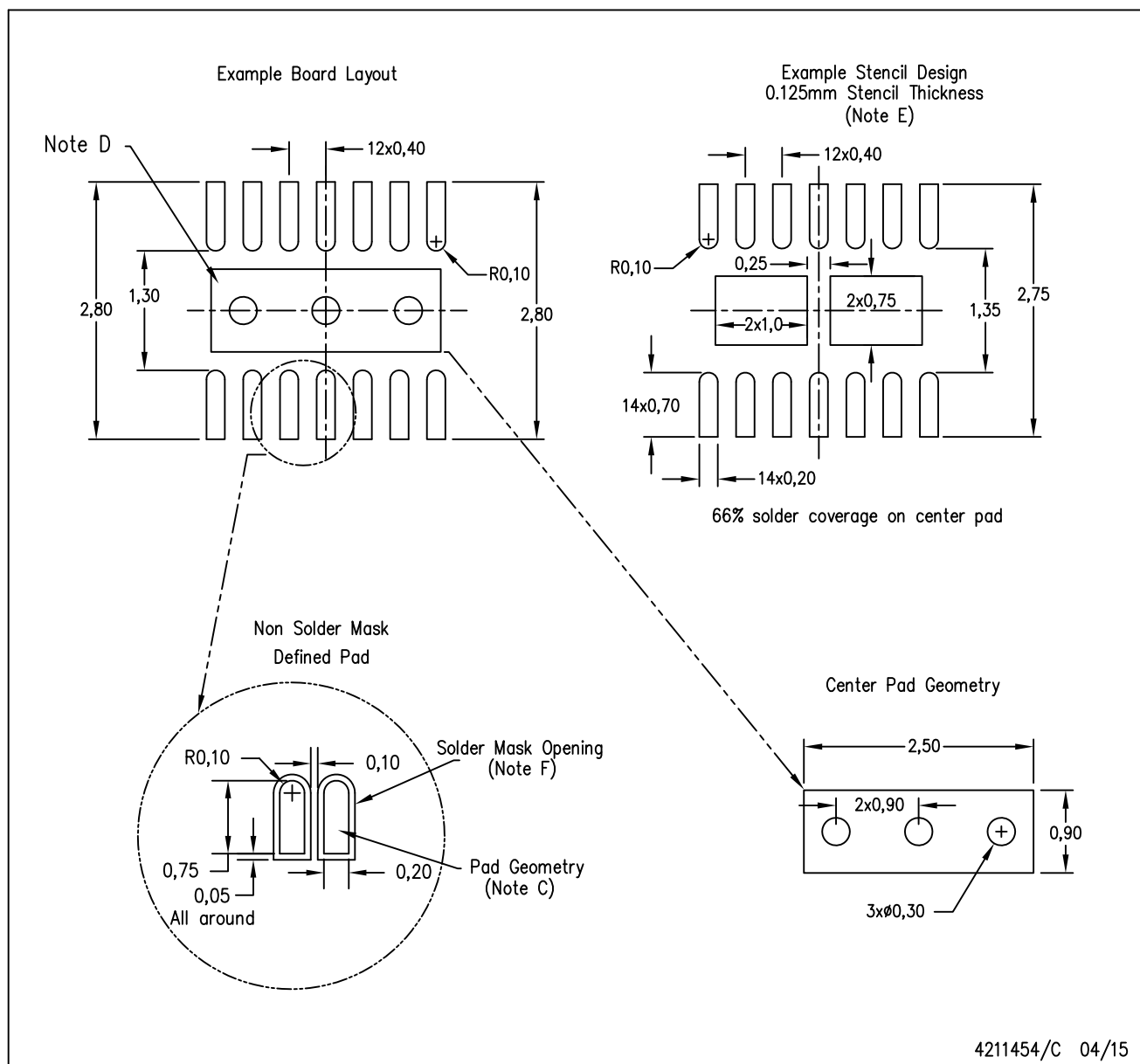
Exposed Thermal Pad Dimensions

4211395/C 04/15

NOTE: All linear dimensions are in millimeters

DPU (R-PWSON-N14)

PLASTIC SMALL OUTLINE NO-LEAD



- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Publication IPC-7351 is recommended for alternate designs.
 - D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <<http://www.ti.com>>.
 - E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
 - F. Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.

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